## Amendments to the Claims

- 1. (previously presented) A method for the manufacture of a high temperature superconducting layer on a substrate comprising the following steps:
  - a. deposition of an RBa<sub>2</sub>Cu<sub>3</sub>O<sub>7</sub>-layer onto the substrate with a low growth rate less than 1 nm/s, wherein R represents yttrium, an element of the group of rare-earth elements (atomic number 57-71) or mixtures of two or more of these elements;
  - b. deposition of an XBa<sub>2</sub>Cu<sub>3</sub>O<sub>7</sub>-layer onto the RBa<sub>2</sub>Cu<sub>3</sub>O<sub>7</sub>-layer with a high growth rate greater than 1 nm/s, wherein X represents yttrium, an element of the group of rare-earth elements (atomic number 57-71) or mixtures of two or more of these elements.
- 2. (previously presented) A method according to claim 1, wherein the high growth rate is greater than 2 nm/s.
- 3. (previously presented) A method according to claim 1, wherein the RBa<sub>2</sub>Cu<sub>3</sub>O<sub>7</sub>-layer comprises a thickness of less than 500 nm.
- 4. (previously presented) A method according to claim 1, wherein the RBa<sub>2</sub>Cu<sub>3</sub>O<sub>7</sub>-layer has a thickness of greater than 5 nm.
- 5. (previously presented) A method according to claim 1, wherein the  $XBa_2Cu_3O_7$ -layer has a thickness of greater than 1  $\mu$ m.
- 6. (previously presented) A method according to claim 1, wherein the RBa<sub>2</sub>Cu<sub>3</sub>O<sub>7</sub>-layer is deposited onto an at least biaxially textured substrate or a substrate with an at least biaxially textured buffer layer.
- 7. (previously presented) A method according to claim 1, wherein the XBa<sub>2</sub>Cu<sub>3</sub>O<sub>7</sub>-layer is deposited as a precursor layer, comprising the metal components of the high temperature superconducting layer.

- 8. (previously presented) A method according to claim 7, wherein the precursor layer is transformed in a further method step by a temperature treatment with a high transformation rate into a superconducting XBa<sub>2</sub>Cu<sub>3</sub>O<sub>7</sub>-layer.
- 9. (previously presented) A method according to claim 8, wherein the transformation rate is greater than 2 nm/s.
- 10. (previously presented) A method according to claim 1, wherein R represents a rare-earth element of the group comprising La, Pr, Nd, Sm, Eu, and Gd, or compounds comprising to at least 50% of one or more of these elements in mixtures with other rare-earth elements.
  - 11. (cancelled)